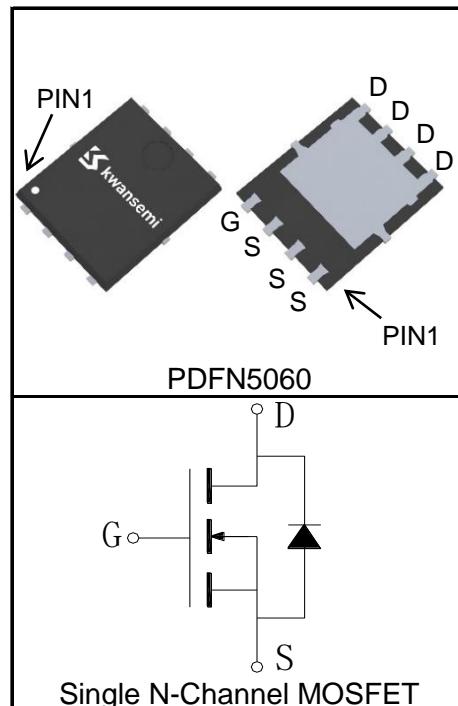


## Features

- 30V/100A,  
 $R_{DS\ (ON)} = 2.3\text{m}\Omega$ (Typ.)@ $V_{GS}=10\text{V}$   
 $R_{DS\ (ON)} = 3.3\text{m}\Omega$ (Typ.)@ $V_{GS}=4.5\text{V}$
- Low  $R_{DS\ (ON)}$
- Super High Dense Cell Design
- Fast Switching Speed
- 100% avalanche tested

## Pin Description



## Applications

- Switching Application Systems



Halogen-Free

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
<b>Common Ratings</b> ( $T_c=25^\circ\text{C}$ Unless Otherwise Noted)			
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	
$T_{Jmax}$	Maximum Junction Temperature	150	$^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_S$	Diode Continuous Forward Current	$T_c=25^\circ\text{C}$	A

### Mounted on Large Heat Sink

$I_{DP}^{(1)}$	Pulse Drain Current	$T_c=25^\circ\text{C}$	400	A
$I_D^{(2)}$	Continuous Drain Current@ $T_c(V_{GS}=10\text{V})$	$T_c=25^\circ\text{C}$	100	A
		$T_c=100^\circ\text{C}$	63	
$P_D$	Continuous Drain Current@ $T_A(V_{GS}=10\text{V})^{(3)}$	$T_A=25^\circ\text{C}$	30	
		$T_A=70^\circ\text{C}$	24	
$P_D$	Maximum Power Dissipation@ $T_c$	$T_c=25^\circ\text{C}$	44	W
		$T_c=100^\circ\text{C}$	17	
	Maximum Power Dissipation@ $T_A$ <sup>(3)</sup>	$T_A=25^\circ\text{C}$	4.2	
		$T_A=70^\circ\text{C}$	2.7	

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2.8	°C/W
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient	30	°C/W
<b>Drain-Source Avalanche Ratings</b>			
$E_{AS}^{(4)}$	Avalanche Energy, Single Pulsed	306	mJ

### Electrical Characteristics ( $T_C=25^\circ C$ Unless Otherwise Noted)

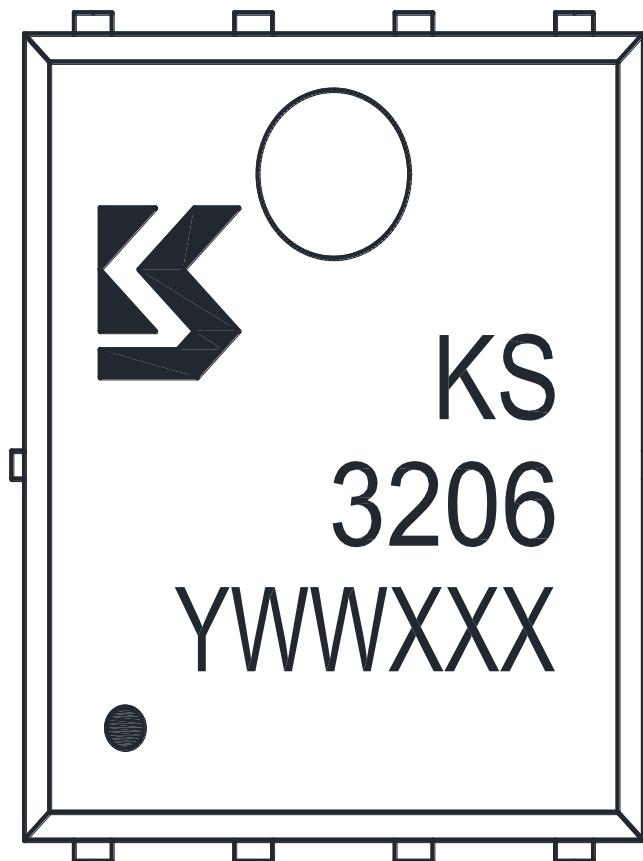
Symbol	Parameter	Test Condition	KS3206NB			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V$			1	$\mu A$
		$T_J=125^\circ C$			30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	1.1	1.5	2.3	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
$R_{DS(ON)}^{(5)}$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=20A$		2.3	3.1	mΩ
		$V_{GS}=4.5V, I_{DS}=16A$		3.3	4.5	mΩ
<b>Diode Characteristics</b>						
$V_{SD}^{(5)}$	Diode Forward Voltage	$I_{SD}=20A, V_{GS}=0V$		0.8	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_{SD}=20A, dI_{SD}/dt=100A/\mu s$		20		ns
$Q_{rr}$	Reverse Recovery Charge			38		nC
<b>Dynamic Characteristics</b> <sup>(6)</sup>						
$R_G$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1MHz$		5		Ω
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=15V, Frequency=1.0MHz$		3595		pF
$C_{oss}$	Output Capacitance			465		
$C_{rss}$	Reverse Transfer Capacitance			400		
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=15V, I_{DS}=20A, V_{GS}=10V, R_G=3\Omega$		14		ns
$t_r$	Turn-on Rise Time			18		
$t_{d(OFF)}$	Turn-off Delay Time			85		
$t_f$	Turn-off Fall Time			39		
<b>Gate Charge Characteristics</b> <sup>(6)</sup>						
$Q_g$	Total Gate Charge	$V_{DS}=15V, V_{GS}=10V, I_{DS}=20A$		66		nC
$Q_{gs}$	Gate-Source Charge			10		
$Q_{gd}$	Gate-Drain Charge			13		

## Notes:

- ①Pulse width limited by safe operating area.
- ②Calculated continuous current based on maximum allowable junction temperature. The package limitation current is 50A.
- ③When mounted on 1 inch square copper board,  $t \leq 10\text{sec}$ .
- ④Limited by  $T_{J\max}$ , Starting  $T_J = 25^\circ\text{C}$ ,  $I_{AS\max} = 35\text{A}$ ,  $L=0.5\text{mH}$ ,  $V_{DD} = 20\text{V}$ ,  $R_G = 25\Omega$ ,  $V_{GS}=10\text{V}$ .Part not recommended for use above this value.100% Final Test at  $I_{AS}=20\text{A}$ ,  $L=0.5\text{mH}$ .
- ⑤Pulse test;Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- ⑥Guaranteed by design, not subject to production testing.

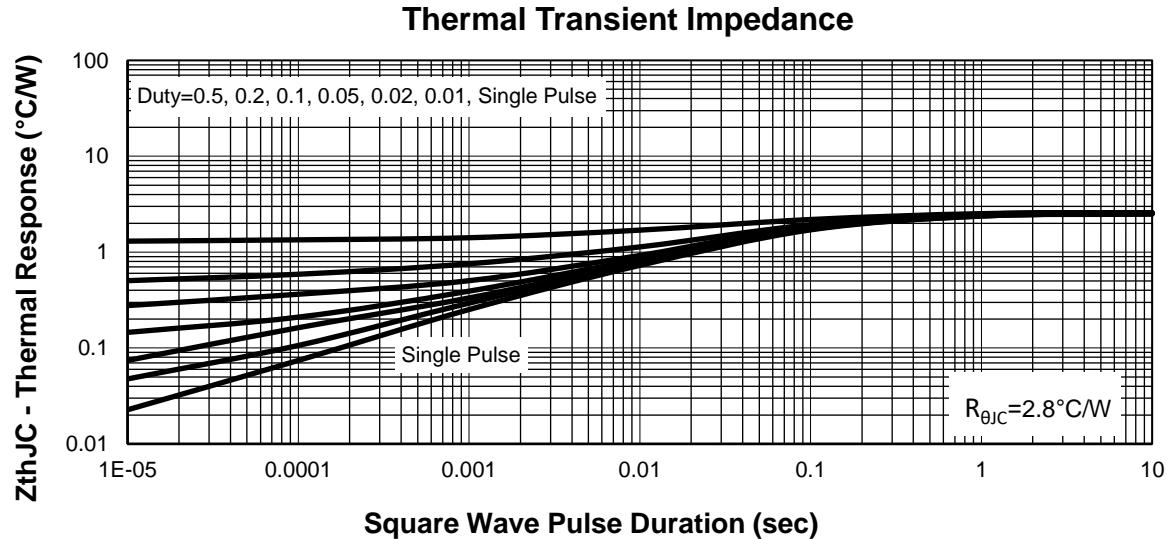
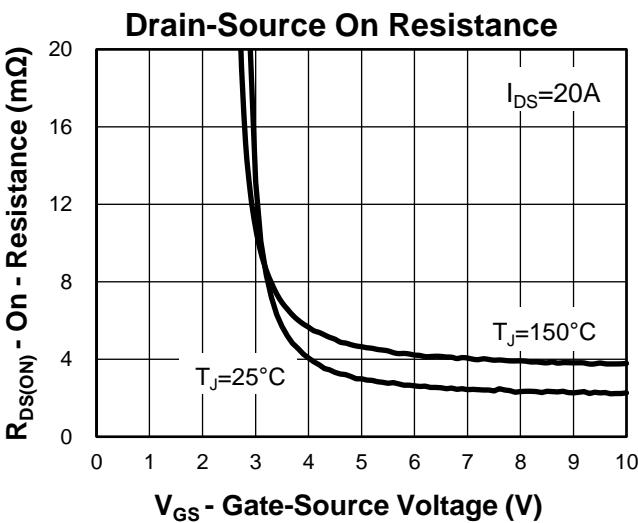
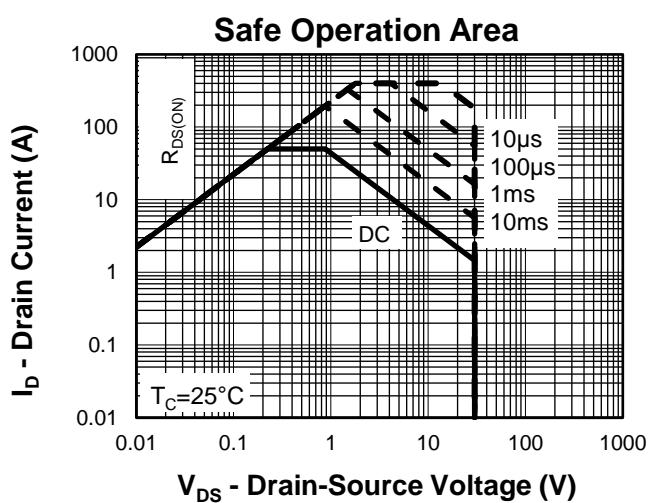
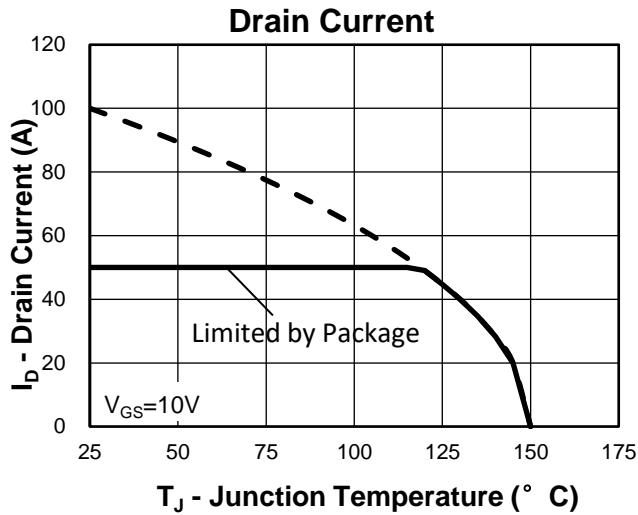
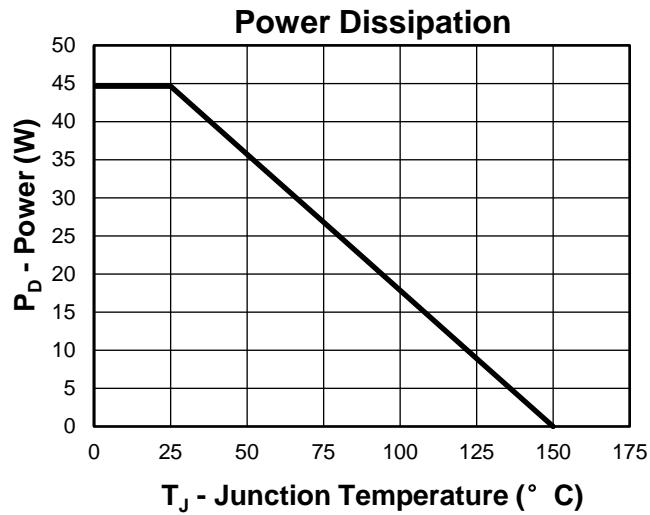
**Ordering and Marking Information**

Device	Package	Packaging	Quantity	Reel Size	Tape width
KS3206NB	PDFN5060	Tape&Reel	5000	13"	12mm

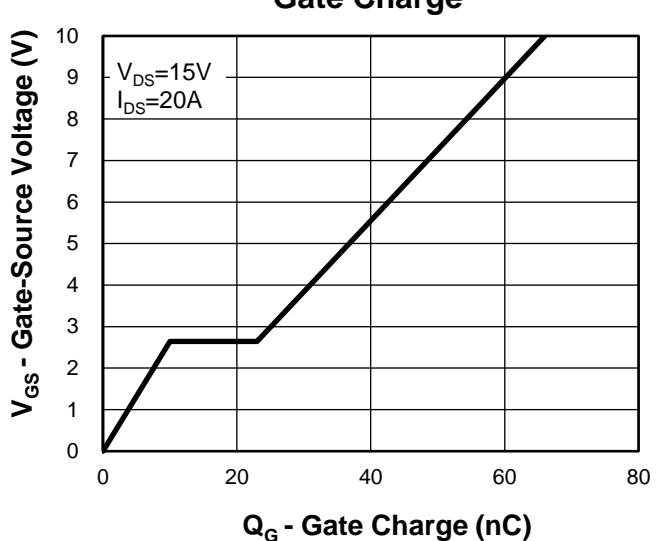
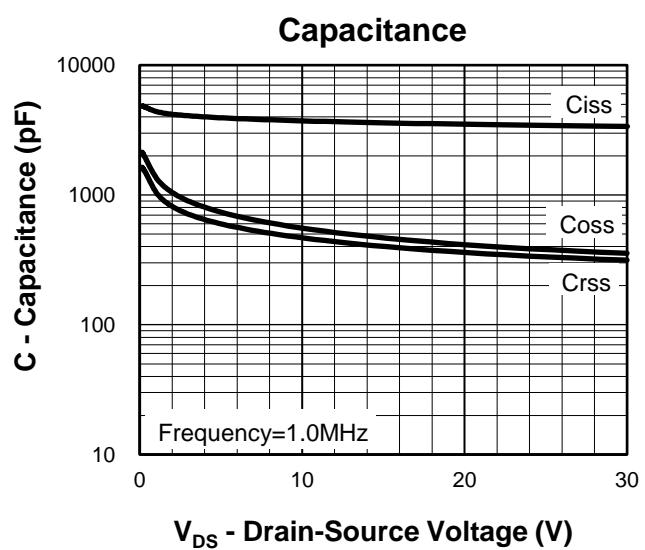
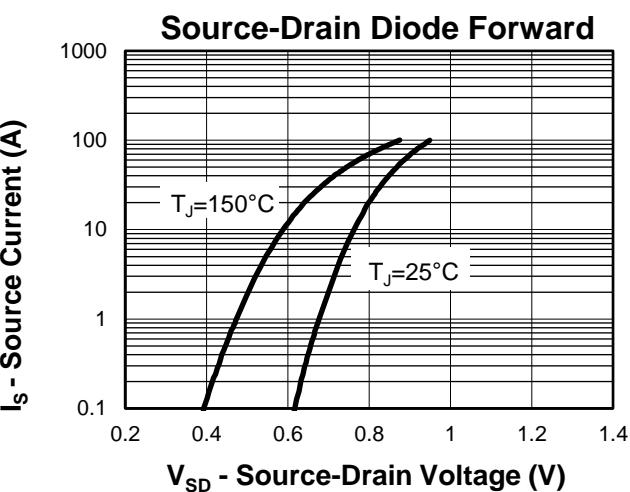
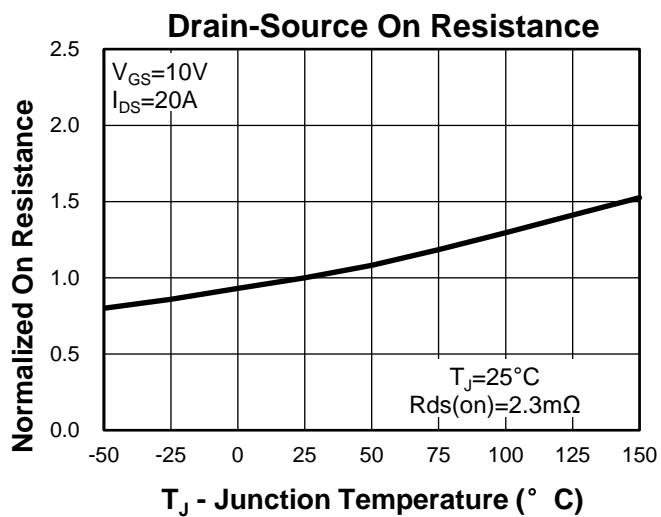
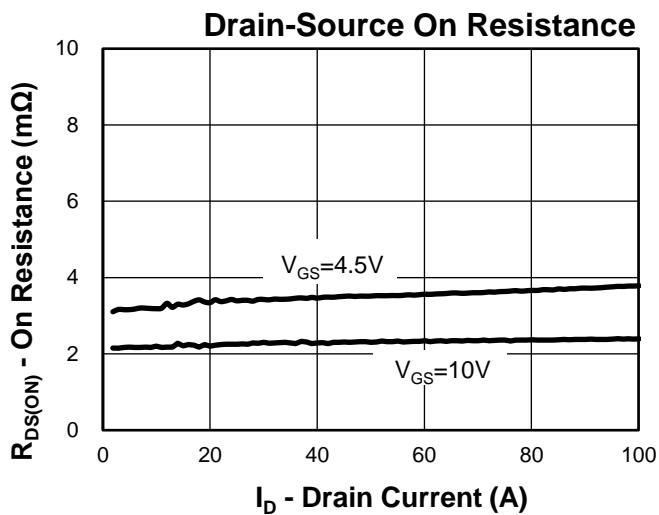
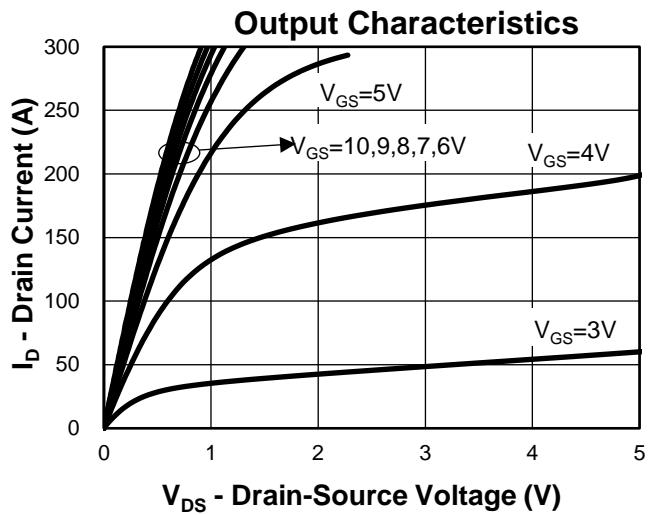


1st Line: Kwansemi LOGO, Kwansemi Code(KS)  
2nd Line: Part Number(3206)  
3rd Line: Lot Number(YWWXXX)

## Typical Characteristics

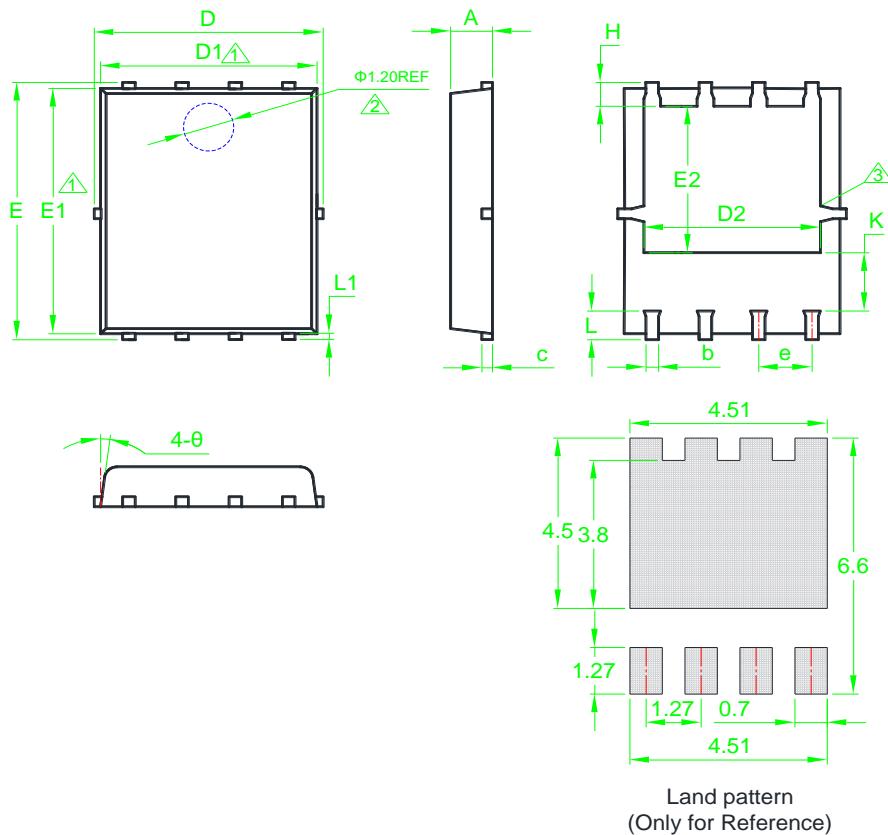


## Typical Characteristics



## Package Information

### PDFN5060



Land pattern  
(Only for Reference)

SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	0.90	1.00	1.20	0.035	0.039	0.047	E2	3.27	3.50	3.90	0.129	0.138	0.154
b	0.25	*	0.50	0.010	*	0.020	e	1.27BSC			0.050BSC		
c	0.20	0.25	0.30	0.008	0.010	0.012	H	0.41	0.51	0.71	0.016	0.020	0.028
D	5.15BSC			0.203BSC			K	1.10	1.35	1.50	0.043	0.053	0.059
D1	4.80	5.00	5.40	0.189	0.197	0.213	L	0.51	0.61	0.71	0.020	0.024	0.028
D2	3.60	*	4.40	0.142	*	0.173	L1	0.06	0.13	0.30	0.002	0.005	0.012
E	5.90	6.15	6.30	0.232	0.242	0.248	θ	0°	*	12°	0°	*	12°
E1	5.40	5.80	5.95	0.213	0.228	0.234							

**1** Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.

**2** The existence and size of demolding hole are variable depending on mold.

**3** The size and shape of exposed pad are variable depending on mold.

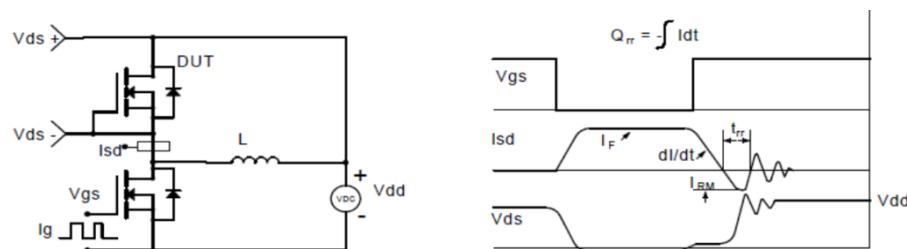
### Avalanche Test Circuit and Waveforms



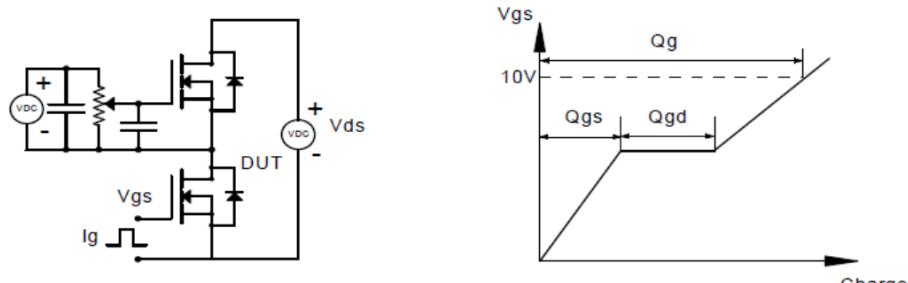
### Switching Time Test Circuit and Waveforms



### Diode Recovery Test Circuit and Waveforms



### Gate Charge Test Circuit and Waveform



### Customer Service

Kwansemi Semiconductor Co.,Ltd

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Web:[www.kwansemi.com](http://www.kwansemi.com)

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